Infineon Technologies - XMC1202T016X0016AAXUMA2 Datasheet

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Applications of "Embedded - Microcontrollers"

Details	
Product Status	Obsolete
Core Processor	ARM® Cortex®-M0
Core Size	32-Bit Single-Core
Speed	32MHz
Connectivity	I²C, LINbus, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, I²S, POR, PWM, WDT
Number of I/O	11
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	16K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 5.5V
Data Converters	A/D 11x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	16-TSSOP (0.173", 4.40mm Width)
Supplier Device Package	PG-TSSOP-16-8
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/xmc1202t016x0016aaxuma2

XMC1200 Data Sheet

Revision History: V1.4 2014-05

Previous Version: V1.3	
Page	Subjects
Page 11	ADC channels of Table 2 is updated. Table 3 is added.
Page 12	Description for Chip Identification Number of Section 1.4 is updated.
Page 10	A new variant XMC1200-T038 is included in Table 1, Table 2 and Table 4.
Page 20	The pad type is corrected for P1.6 in Table 6.
Page 32	The t_{C12} , f_{C12}, t_{C10}, f_{C10}, t_{C8} and f_{C8} parameters are updated in Table 12.
Page 35	Figure 9 is added.
Page 38	The t_{SR} and t_{TSAL} parameters are updated in Table 15.
Page 41	Parameter name for t_{PSER} is updated. The $N_{WSFLASH}$ parameter and test condition for t_{RET} are added to Table 18.
Page 44	The min value for V_{DDPBO} parameter is added to Table 20. Footnote 1 is updated.
Page 46	The Δf_{LTT} parameter is added to Table 21.
Page 47	Figure 15 is added.

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Table 1 Synopsis of XMC1200 Device Types (cont'd)

Derivative	Package	Flash Kbytes	SRAM Kbytes
XMC1200-T038F0200	PG-TSSOP-38-9	200	16
XMC1202-T028X0016	PG-TSSOP-28-16	16	16
XMC1202-T028X0032	PG-TSSOP-28-16	32	16
XMC1202-T016X0016	PG-TSSOP-16-8	16	16
XMC1202-T016X0032	PG-TSSOP-16-8	32	16
XMC1202-Q024X0016	PG-VQFN-24-19	16	16
XMC1202-Q024X0032	PG-VQFN-24-19	32	16
XMC1201-Q040F0016	PG-VQFN-40-13	16	16
XMC1201-Q040F0032	PG-VQFN-40-13	32	16
XMC1201-Q040F0064	PG-VQFN-40-13	64	16
XMC1201-Q040F0128	PG-VQFN-40-13	128	16
XMC1201-Q040F0200	PG-VQFN-40-13	200	16
XMC1202-Q040X0016	PG-VQFN-40-13	16	16
XMC1202-Q040X0032	PG-VQFN-40-13	32	16

1.3 Device Type Features

The following table lists the available features per device type.

Table 2 Features of XMC1200 Device Types[1)]

Derivative	ADC channel	ACMP	BCCU	LEDTS
XMC1200-T038	16	3	1	2
XMC1201-T038	16	-	-	2
XMC1202-T028	14	3	1	-
XMC1202-T016	11	2	1	-
XMC1202-Q024	13	3	1	-
XMC1201-Q040	16	-	-	2
XMC1202-Q040	16	3	1	-

1) Features that are not included in this table are available in all the derivatives

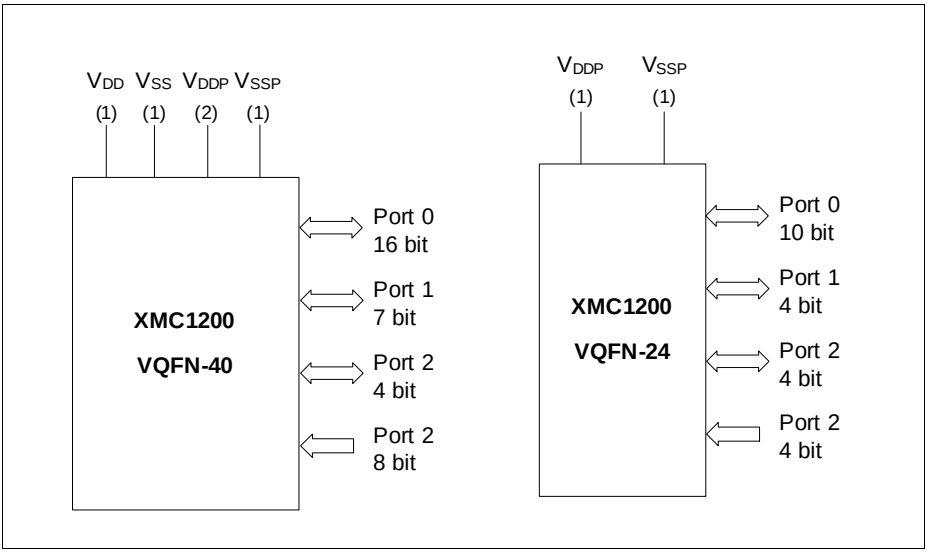

Figure 3 XMC1200 Logic Symbol for VQFN-24 and VQFN-40

2.2 Pin Configuration and Definition

The following figures summarize all pins, showing their locations on the different packages.

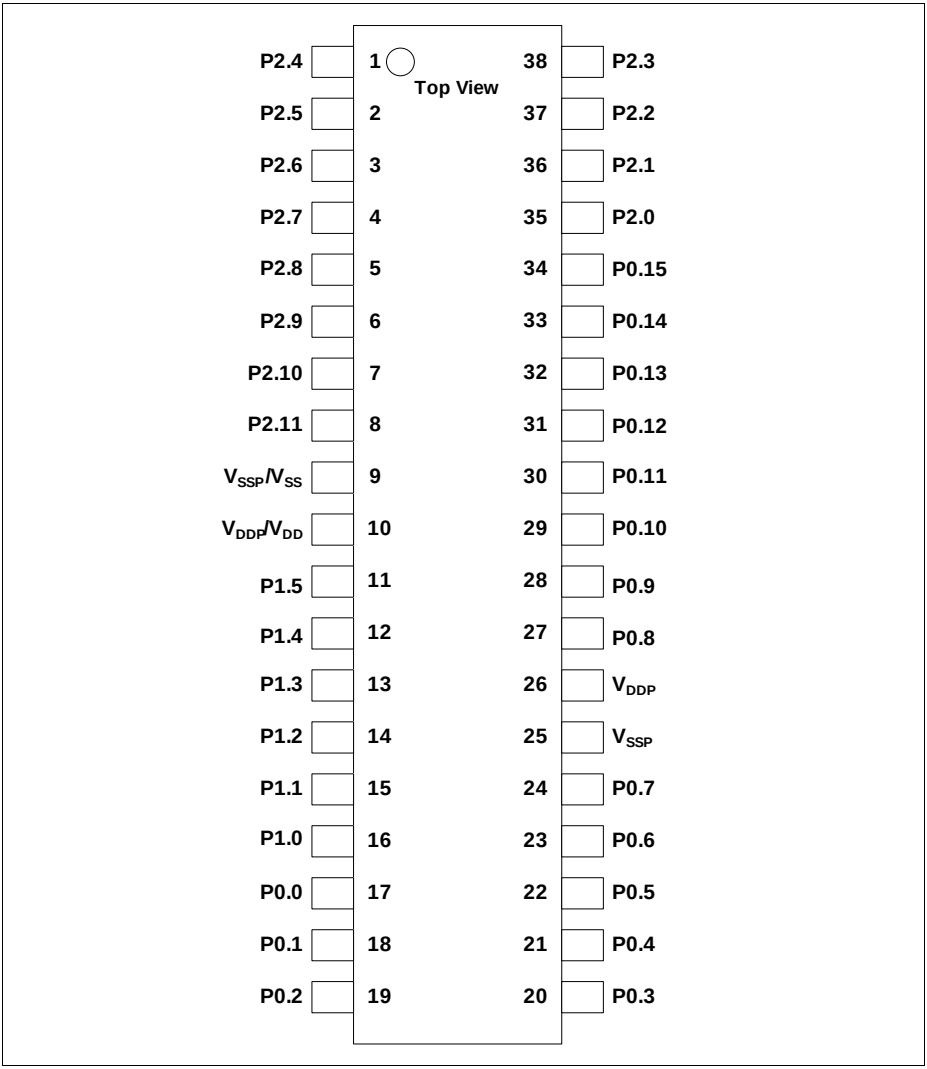

Figure 4 XMC1200 PG-TSSOP-38 Pin Configuration (top view)

Table 6 Package Pin Mapping

Function	VQFN 40	TSSOP 38	TSSOP 28	VQFN 24	TSSOP 16	Pad Type	Notes
P0.13	38	32	22	22	-	STD_INOUT	
P0.14	39	33	23	23	13	STD_INOUT	
P0.15	40	34	24	24	14	STD_INOUT	
P1.0	22	16	12	14	-	High Current	
P1.1	21	15	11	13	-	High Current	
P1.2	20	14	10	12	-	High Current	
P1.3	19	13	9	11	-	High Current	
P1.4	18	12	-	-	-	High Current	
P1.5	17	11	-	-	-	High Current	
P1.6	16	-	-	-	-	STD_INOUT	
P2.0	1	35	25	1	15	STD_INOUT /AN	
P2.1	2	36	26	2	-	STD_INOUT /AN	
P2.2	3	37	27	3	-	STD_IN/AN	
P2.3	4	38	-	-	-	STD_IN/AN	
P2.4	5	1	-	-	-	STD_IN/AN	
P2.5	6	2	28	-	-	STD_IN/AN	
P2.6	7	3	1	4	16	STD_IN/AN	
P2.7	8	4	2	5	1	STD_IN/AN	
P2.8	9	5	3	5	1	STD_IN/AN	
P2.9	10	6	4	6	2	STD_IN/AN	
P2.10	11	7	5	7	3	STD_INOUT /AN	
P2.11	12	8	6	8	4	STD_INOUT /AN	
VSS	13	9	7	9	5	Power	Supply GND, ADC reference GND

2.2.2 Port I/O Functions

The following general building block is used to describe each PORT pin:

Table 7 Port I/O Function Description

Function	Outputs			Inputs		
	ALT1	ALTn	HWO0	HWI0	Input	Input
P0.0		MODA.OUT	MODB.OUT	MODB.INA	MODC.INA	
Pn.y	MODA.OUT				MODA.INA	MODC.INB

Pn.y is the port pin name, defining the control and data bits/registers associated with it. As GPIO, the port is under software control. Its input value is read via Pn_IN.y, Pn_OUT defines the output value.

Up to seven alternate output functions (ALT1/2/3/4/5/6/7) can be mapped to a single port pin, selected by Pn_IOCR.PC. The output value is directly driven by the respective module, with the pin characteristics controlled by the port registers (within the limits of the connected pad).

The port pin input can be connected to multiple peripherals. Most peripherals have an input multiplexer to select between different possible input sources.

The input path is also active while the pin is configured as output. This allows to feedback an output to on-chip resources without wasting an additional external pin.

By Pn_HWSEL, it is possible to select between different hardware “masters” (HWO0/HWI0, HWO1/HWI1). The selected peripheral can take control of the pin(s). Hardware control overrules settings in the respective port pin registers.

Table 8 Port I/O Functions

Function	Outputs									Inputs									
	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7	HWO0	HWO1	HWI0	HWI1	Input	Input	Input	Input	Input	Input	Input	Input
P0.0	ERU0. PDOUT0	LEDTS0. LINE7	ERU0. GOUT0	CCU40. OUT0		USIC0_CH0. SELO0	USIC0_CH1. SELO0	LEDTS0. EXTENDED7		LEDTS0. TSIN7	LEDTS0. TSIN7	BCCU0. TRAPINB	CCU40.IN0C			USIC0_CH0. DX2A	USIC0_CH1. DX2A		
P0.1	ERU0. PDOUT1	LEDTS0. LINE6	ERU0. GOUT1	CCU40. OUT1		BCCU0. OUT8	SCU. VDROP	LEDTS0. EXTENDED6		LEDTS0. TSIN6	LEDTS0. TSIN6		CCU40.IN1C						
P0.2	ERU0. PDOUT2	LEDTS0. LINE5	ERU0. GOUT2	CCU40. OUT2		VADC0. EMUX02		LEDTS0. EXTENDED5		LEDTS0. TSIN5	LEDTS0. TSIN5		CCU40.IN2C						
P0.3	ERU0. PDOUT3	LEDTS0. LINE4	ERU0. GOUT3	CCU40. OUT3		VADC0. EMUX01		LEDTS0. EXTENDED4		LEDTS0. TSIN4	LEDTS0. TSIN4		CCU40.IN3C						
P0.4	BCCU0. OUT0	LEDTS0. LINE3	LEDTS0. COL3	CCU40. OUT1		VADC0. EMUX00	WWDT. SERVICE_OUT	LEDTS0. EXTENDED3		LEDTS0. TSIN3	LEDTS0. TSIN3								
P0.5	BCCU0. OUT1	LEDTS0. LINE2	LEDTS0. COL2	CCU40. OUT0		ACMP2. OUT		LEDTS0. EXTENDED2		LEDTS0. TSIN2	LEDTS0. TSIN2								
P0.6	BCCU0. OUT2	LEDTS0. LINE1	LEDTS0. COL1	CCU40. OUT0		USIC0_CH1. MCLKOUT	USIC0_CH1. DOUT0	LEDTS0. EXTENDED1		LEDTS0. TSIN1	LEDTS0. TSIN1		CCU40.IN0B			USIC0_CH1. DX0C			
P0.7	BCCU0. OUT3	LEDTS0. LINE0	LEDTS0. COL0	CCU40. OUT1		USIC0_CH0. SCLKOUT	USIC0_CH1. DOUT0	LEDTS0. EXTENDED0		LEDTS0. TSIN0	LEDTS0. TSIN0		CCU40.IN1B			USIC0_CH0. DX1C	USIC0_CH1. DX0D	USIC0_CH1. DX1C	
P0.8	BCCU0. OUT4	LEDTS1. LINE0	LEDTS0. COLA	CCU40. OUT2		USIC0_CH0. SCLKOUT	USIC0_CH1. SCLKOUT	LEDTS1. EXTENDED0		LEDTS1. TSIN0	LEDTS1. TSIN0		CCU40.IN2B			USIC0_CH0. DX1B	USIC0_CH1. DX1B		
P0.9	BCCU0. OUT5	LEDTS1. LINE1	LEDTS0. COL6	CCU40. OUT3		USIC0_CH0. SELO0	USIC0_CH1. SELO0	LEDTS1. EXTENDED1		LEDTS1. TSIN1	LEDTS1. TSIN1		CCU40.IN3B			USIC0_CH0. DX2B	USIC0_CH1. DX2B		
P0.10	BCCU0. OUT6	LEDTS1. LINE2	LEDTS0. COL5	ACMP0. OUT		USIC0_CH0. SELO1	USIC0_CH1. SELO1	LEDTS1. EXTENDED2		LEDTS1. TSIN2	LEDTS1. TSIN2					USIC0_CH0. DX2C	USIC0_CH1. DX2C		
P0.11	BCCU0. OUT7	LEDTS1. LINE3	LEDTS0. COL4	USIC0_CH0. MCLKOUT		USIC0_CH0. SELO2	USIC0_CH1. SELO2	LEDTS1. EXTENDED3		LEDTS1. TSIN3	LEDTS1. TSIN3					USIC0_CH0. DX2D	USIC0_CH1. DX2D		
P0.12	BCCU0. OUT6	LEDTS1. LINE4	LEDTS0. COL3	LEDTS1. COL3		USIC0_CH0. SELO3		LEDTS1. EXTENDED4		LEDTS1. TSIN4	LEDTS1. TSIN4	BCCU0. TRAPINA	CCU40.IN0A	CCU40.IN1A	CCU40.IN2A	CCU40.IN3A	USIC0_CH0. DX2E		
P0.13	WWDT. SERVICE_OUT	LEDTS1. LINE5	LEDTS0. COL2	LEDTS1. COL2		USIC0_CH0. SELO4		LEDTS1. EXTENDED5		LEDTS1. TSIN5	LEDTS1. TSIN5					USIC0_CH0. DX2F			
P0.14	BCCU0. OUT7	LEDTS1. LINE6	LEDTS0. COL1	LEDTS1. COL1		USIC0_CH0. DOUT0	USIC0_CH0. SCLKOUT	LEDTS1. EXTENDED6		LEDTS1. TSIN6	LEDTS1. TSIN6					USIC0_CH0. DX0A	USIC0_CH0. DX1A		
P0.15	BCCU0. OUT8	LEDTS1. LINE7	LEDTS0. COL0	LEDTS1. COL0		USIC0_CH0. DOUT0	USIC0_CH1. MCLKOUT	LEDTS1. EXTENDED7		LEDTS1. TSIN7	LEDTS1. TSIN7					USIC0_CH0. DX0B			
P1.0	BCCU0. OUT0	CCU40. OUT0	LEDTS0. COL0	LEDTS1. COLA		ACMP1. OUT	USIC0_CH0. DOUT0		USIC0_CH0. DOUT0		USIC0_CH0. HWIN0					USIC0_CH0. DX0C			
P1.1	VADC0. EMUX00	CCU40. OUT1	LEDTS0. COL1	LEDTS1. COL0		USIC0_CH0. DOUT0	USIC0_CH1. SELO0		USIC0_CH0. DOUT1		USIC0_CH0. HWIN1					USIC0_CH0. DX0D	USIC0_CH0. DX1D	USIC0_CH1. DX2E	
P1.2	VADC0. EMUX01	CCU40. OUT2	LEDTS0. COL2	LEDTS1. COL1		ACMP2. OUT	USIC0_CH1. DOUT0		USIC0_CH0. DOUT2		USIC0_CH0. HWIN2					USIC0_CH1. DX0B			
P1.3	VADC0. EMUX02	CCU40. OUT3	LEDTS0. COL3	LEDTS1. COL2		USIC0_CH1. SCLKOUT	USIC0_CH1. DOUT0		USIC0_CH0. DOUT3		USIC0_CH0. HWIN3					USIC0_CH1. DX0A	USIC0_CH1. DX1A		
P1.4	VADC0. EMUX10	USIC0_CH1. SCLKOUT	LEDTS0. COL4	LEDTS1. COL3		USIC0_CH0. SELO0	USIC0_CH1. SELO1									USIC0_CH0. DX5E	USIC0_CH1. DX5E		
P1.5	VADC0. EMUX11	USIC0_CH0. DOUT0	LEDTS0. COLA	BCCU0. OUT1		USIC0_CH0. SELO1	USIC0_CH1. SELO2									USIC0_CH1. DX5F			

3.1.2 Absolute Maximum Ratings

Stresses above the values listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions may affect device reliability.

Table 9 Absolute Maximum Rating Parameters

Parameter	Symbol		Values			Unit	Note / Test Condition
			Min.	Typ.	Max.		
Junction temperature	T_J	SR	-40	–	115	°C	–
Storage temperature	T_S	SR	-40	–	125	°C	–
Voltage on power supply pin with respect to V_{SSP}	V_{DDP}	SR	-0.3	–	6	V	–
Voltage on any pin with respect to V_{SSP}	V_{IN}	SR	-0.5	–	V_{DDP} + 0.5 or max. 6	V	whichever is lower
Voltage on any analog input pin with respect to V_{SSP}	V_{AIN} V_{AREF}	SR	-0.5	–	V_{DDP} + 0.5 or max. 6	V	–
Input current on any pin during overload condition	I_{IN}	SR	-10	–	10	mA	–
Absolute sum of all input currents during overload condition	$\Sigma\|I_{IN}\|$	SR	–	–	50	mA	–
Analog comparator input voltage	V_{CM}	SR	-0.3	–	V_{DDP} + 0.3	V	

Table 12 ADC Characteristics (Operating Conditions apply) (cont'd)

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Maximum sample rate in 8-bit mode [3]	f_{C8} CC	–	–	f_{ADC} / 38.5	–	1 sample pending
		–	–	f_{ADC} / 54.5	–	2 samples pending
DNL error	EA_{DNL} CC	–	±2.0	–	LSB 12	
INL error	EA_{INL} CC	–	±4.0	–	LSB 12	
Gain error with external reference	EA_{GAIN} CC	–	±0.5	–	%	SHSCFG.AREF = 00_B (calibrated)
Gain error with internal reference	EA_{GAIN} CC	–	±3.6	–	%	SHSCFG.AREF = $1X_B$ (calibrated), -40°C - 105°C
		–	±2.0	–	%	SHSCFG.AREF = $1X_B$ (calibrated), 0°C - 85°C
Offset error	EA_{OFF} CC	–	±6.0	–	LSB 12	Calibrated

1) Not subject to production test, verified by design/characterization.

2) No pending samples assumed, excluding sampling time and calibration.

3) Includes synchronization and calibration (average of gain and offset calibration).

3.2.4 Analog Comparator Characteristics

Table 14 below shows the Analog Comparator characteristics.

Table 14 Analog Comparator Characteristics (Operating Conditions apply)

Parameter	Symbol		Limit Values			Unit	Notes/ Test Conditions
			Min.	Typ.	Max.		
Input Voltage	V_{CMP}	SR	-0.05	–	V_{DDP} + 0.05	V	
Input Offset	V_{CMPOFF}	CC	–	+/-3	–	mV	High power mode ΔV_{CMP} < 200 mV
			–	+/-20	–	mV	Low power mode[2] ΔV_{CMP} < 200 mV
Propagation Delay[1][2]	t_{PDELAY}	CC	–	25	–	ns	High power mode, ΔV_{CMP} = 100 mV
			–	80	–	ns	High power mode, ΔV_{CMP} = 25 mV
			–	250	–	ns	Low power mode, ΔV_{CMP} = 100 mV
			–	700	–	ns	Low power mode, ΔV_{CMP} = 25 mV
Current Consumption[2]	I_{ACMP}	CC	–	100	–	µA	First active ACMP in high power mode, ΔV_{CMP} > 30 mV
			–	66	–	µA	Each additional ACMP in high power mode, ΔV_{CMP} > 30 mV
			–	10	–	µA	First active ACMP in low power mode
			–	6	–	µA	Each additional ACMP in low power mode
Input Hysteresis[2]	V_{HYS}	CC	–	15	–	mV	
Filter Delay[1][2]	t_{FDELAY}	CC	–	5	–	ns	

1) Total Analog Comparator Delay is the sum of Propagation Delay and Filter Delay.

2) Not subject to production test, verified by design.

Table 17 provides the active current consumption of some modules operating at 5 V power supply at 25 °C. The typical values shown are used as a reference guide on the current consumption when these modules are enabled.

Table 17 Typical Active Current Consumption[1)]

Active Current Consumption	Symbol	Limit Values	Unit	Test Condition
		Typ.		
Baseload current	I_{CPUDDC}	5.04	mA	Modules including Core, SCU, PORT, memories, ANATOP[2)]
VADC and SHS	I_{ADCDDC}	3.4	mA	Set CGATCLR0.VADC to 1[3)]
USIC0	$I_{USIC0DDC}$	0.87	mA	Set CGATCLR0.USIC0 to 1[4)]
CCU40	$I_{CCU40DDC}$	0.94	mA	Set CGATCLR0.CCU40 to 1[5)]
LEDTSx	$I_{LTSxDDC}$	0.76	mA	Set CGATCLR0.LEDTSx to 1[6)]
BCCU0	$I_{BCCU0DDC}$	0.24	mA	Set CGATCLR0.BCCU0 to 1[7)]
WDT	I_{WDTDDC}	0.03	mA	Set CGATCLR0.WDT to 1[8)]
RTC	I_{RTCDDC}	0.01	mA	Set CGATCLR0.RTC to 1[9)]

1) Not subject to production test, verified by design/characterisation.

2) Baseload current is measured with device running in user mode, MCLK=PCLK=32 MHz, with an endless loop in the flash memory. The clock to the modules stated in CGATSTAT0 are gated.

3) Active current is measured with: module enabled, MCLK=32 MHz, running in auto-scan conversion mode

4) Active current is measured with: module enabled, alternating messages sent to PC at 57.6kbaud every 200ms

5) Active current is measured with: module enabled, MCLK=PCLK=32 MHz, 1 CCU4 slice for PWM switching from 1500Hz and 1000Hz at regular intervals, 1 CCU4 slice in capture mode for reading period and duty cycle

6) Active current is measured with: module enabled, MCLK=32 MHz, 1 LED column, 6 LED/TS lines, Pad Scheme A with large pad hysteresis config, time slice duration = 1.048 ms

7) Active current is measured with: module enabled, MCLK=32 MHz, PCLK=64MHz, FCLK=0.8MHz, Normal mode (BCCU Clk = FCLK/4), 3 BCCU Channels and 1 Dimming Engine, change color or dim every 1s

8) Active current is measured with: module enabled, MCLK=32 MHz, time-out mode; WLB = 0, WUB = 0x00008000; WDT serviced every 1s

9) Active current is measured with: module enabled, MCLK=32 MHz, Periodic interrupt enabled

3.3 AC Parameters

3.3.1 Testing Waveforms

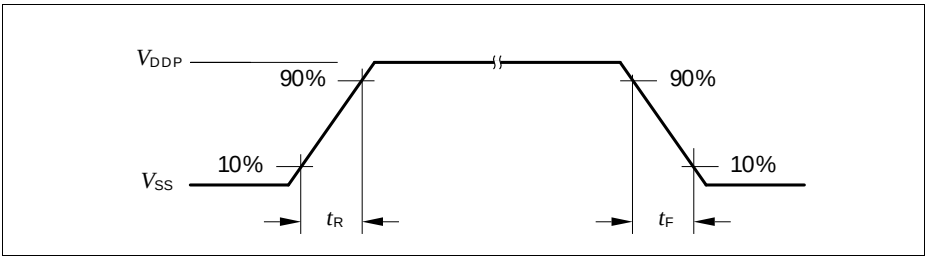

Figure 11 Rise/Fall Time Parameters

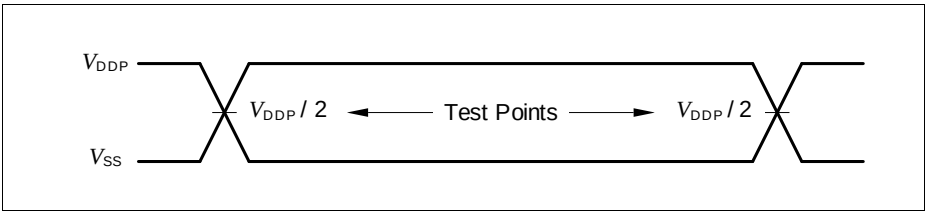

Figure 12 Testing Waveform, Output Delay

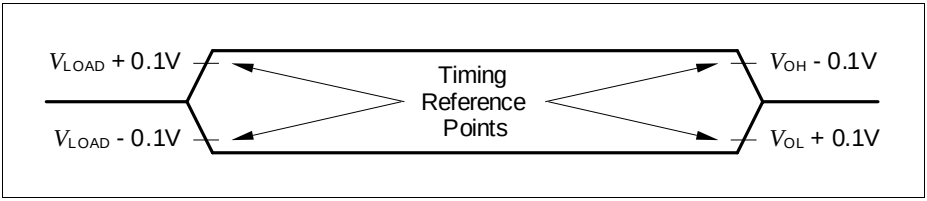

Figure 13 Testing Waveform, Output High Impedance

3) Valid for a 100 nF buffer capacitor connected to supply pin where current from capacitor is forwarded only to the chip. A larger capacitor value has to be chosen if the power source sink a current.

4) This values does not include the ramp-up time. During startup firmware execution, MCLK is running at 32 MHz and the clocks to peripheral as specified in register CGATSTAT0 are gated.

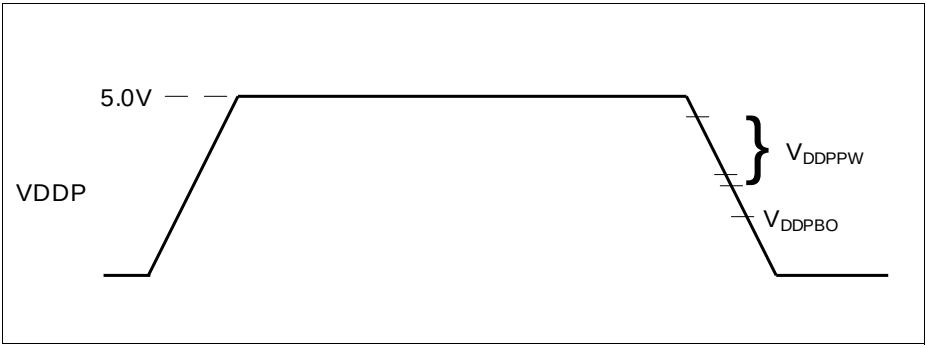

Figure 14 Supply Threshold Parameters

3.3.4 On-Chip Oscillator Characteristics

Table 21 provides the characteristics of the 64 MHz clock output from the digital controlled oscillator, DCO1 in XMC1200.

Table 21 64 MHz DCO1 Characteristics (Operating Conditions apply)

Parameter	Symbol		Limit Values			Unit	Test Conditions
			Min.	Typ.	Max.		
Nominal frequency	f_{NOM}	CC	63.5	64	64.5	MHz	under nominal conditions[1] after trimming
Accuracy	Δf_{LT}	CC	-1.7	–	3.4	%	with respect to f_{NOM}(typ), over temperature (0 °C to 85 °C)[2]
			-3.9	–	4.0	%	with respect to f_{NOM}(typ), over temperature (-40 °C to 105 °C)[2]
Accuracy with calibration based on temperature sensor	Δf_{LTT}	CC	-1.3	–	1.25	%	with respect to f_{NOM}(typ), over temperature (T_A = 0 °C to 105 °C)[2]
			-2.6	–	1.25	%	with respect to f_{NOM}(typ), over temperature (T_A = -40 °C to 105 °C)[2]

1) The deviation is relative to the factory trimmed frequency at nominal V_{DDC} and T_A = + 25 °C.

2) Not subject to production test, verified by design/characterisation.

Table 28 USIC IIC Fast Mode Timing [1)]

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Fall time of both SDA and SCL	t_1 CC/SR	20 + 0.1*C_b [2)]	-	300	ns	
Rise time of both SDA and SCL	t_2 CC/SR	20 + 0.1*C_b	-	300	ns	
Data hold time	t_3 CC/SR	0	-	-	µs	
Data set-up time	t_4 CC/SR	100	-	-	ns	
LOW period of SCL clock	t_5 CC/SR	1.3	-	-	µs	
HIGH period of SCL clock	t_6 CC/SR	0.6	-	-	µs	
Hold time for (repeated) START condition	t_7 CC/SR	0.6	-	-	µs	
Set-up time for repeated START condition	t_8 CC/SR	0.6	-	-	µs	
Set-up time for STOP condition	t_9 CC/SR	0.6	-	-	µs	
Bus free time between a STOP and START condition	t_{10} CC/SR	1.3	-	-	µs	
Capacitive load for each bus line	C_b SR	-	-	400	pF	

1) Due to the wired-AND configuration of an IIC bus system, the port drivers of the SCL and SDA signal lines need to operate in open-drain mode. The high level on these lines must be held by an external pull-up device, approximalely 10 kOhm for operation at 100 kbit/s, approximately 2 kOhm for operation at 400 kbit/s.

2) C_b refers to the total capacitance of one bus line in pF.

4.2 Package Outlines

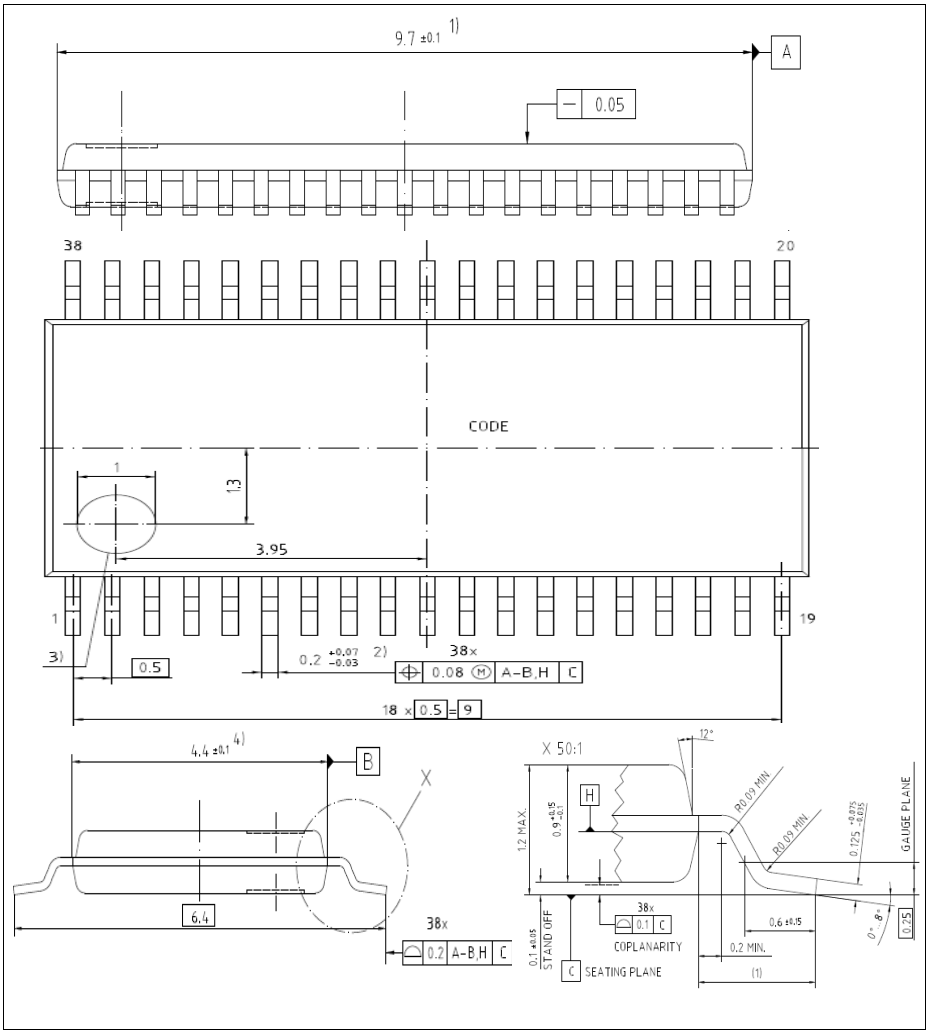

Figure 21 PG-TSSOP-38-9

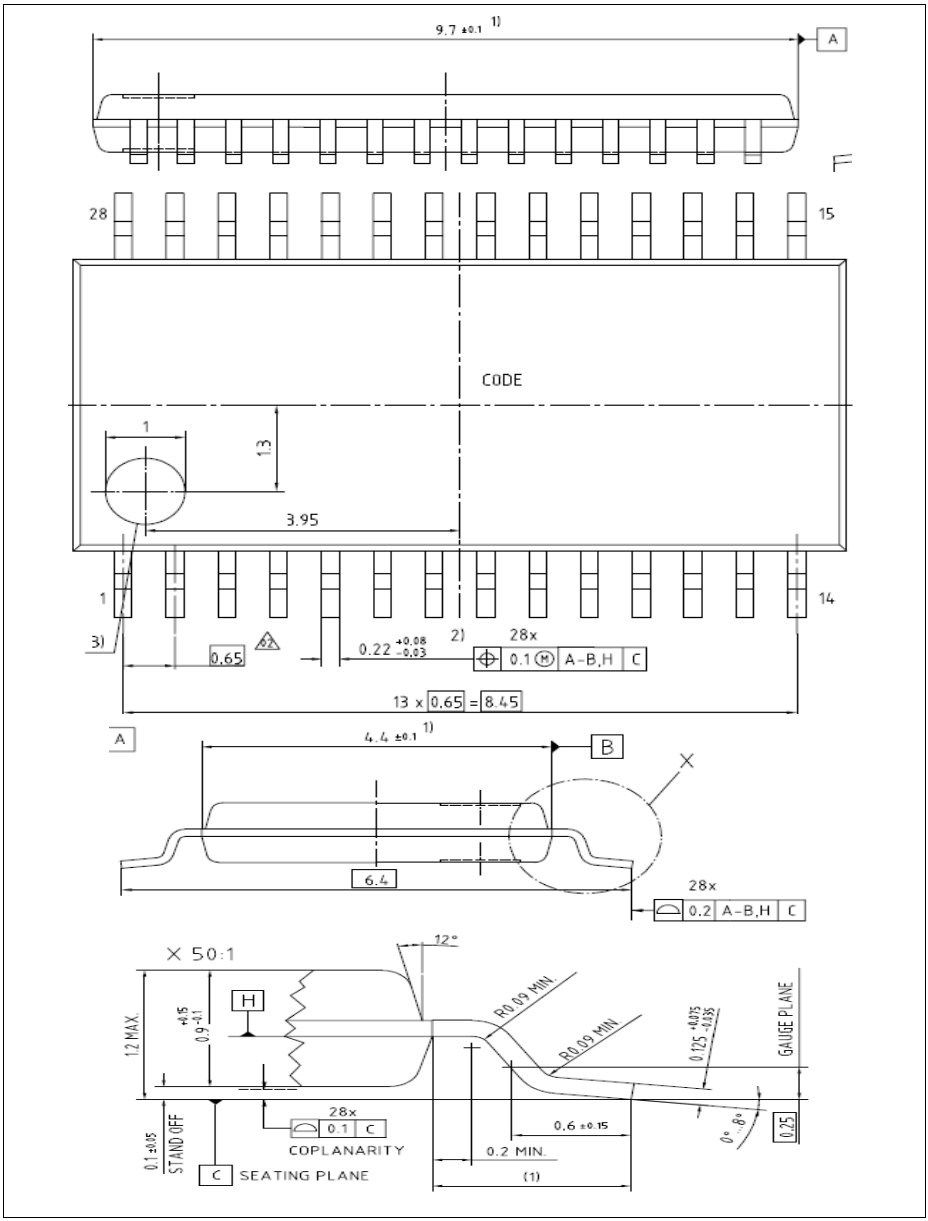

Figure 22 PG-TSSOP-28-16

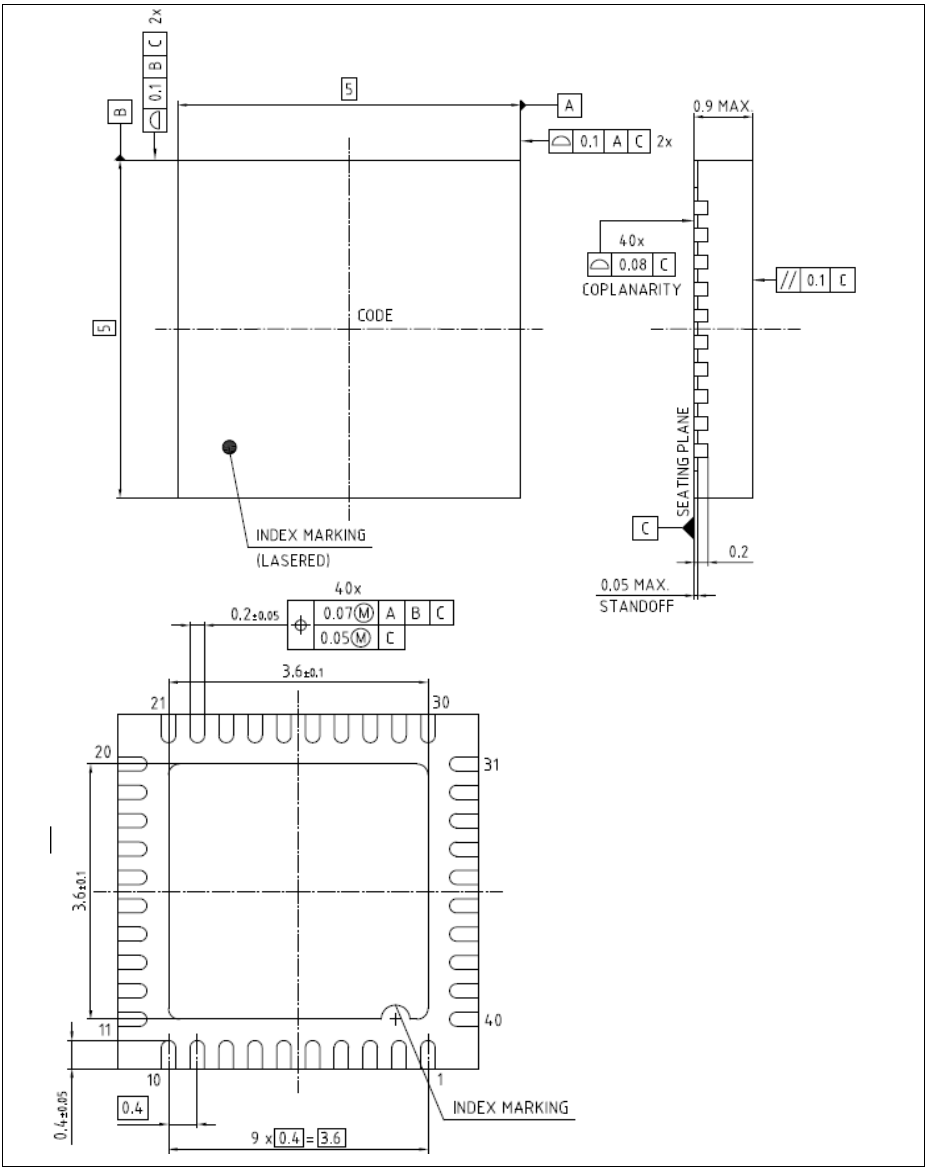

Figure 25 PG-VQFN-40-13

All dimensions in mm.